

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10506766	BIGEY ET AL.
	Examiner Shin, Dana	Art Unit 1635

SEARCHED

Class	Subclass	Date	Examiner
435	6, 15, 193	9-15-06, 5-14-07	DS
514	44	9-15-06, 5-14-07	DS
536	24.5	9-15-06, 5-14-07	DS

SEARCH NOTES

Search Notes	Date	Examiner
EAST - updated, search results attached	5-14-07	DS

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner